Sheet <u>1</u> of <u>1</u> LIST OF REFERENCES CITED BY  APPLICANT									Atty. Docket No 4685	Serial No.: 10/829,306				
									Applicant: Shinsuke FUJIWARA et al.					
(REVISED FORM PTO-1449) DATED: April 20, 2004									U.S. Filing Date: April 20, 2004			Art Unit:		
U. S. PATENT DOCUMENTS														
*EXAMINER INITIAL		DOCUMENT NO.							DATE	NAME	Cl.	Sub- Cl.	Fil. Date	
A.O.A	AA	5	3	7	5	1	3	4	12/1994	Okuyama et al.	-	•	-	
FOREIGN PATENT DOCUMENTS														
		DOCUMENT NO.							DATE	COUNTRY	cı.	Sub- Cl.	Trans.	
													Yes	No
A.O.A.	AB	05	0	7	5	2	1	7	03/1993	Japan	-	1	=AA	
OTHER DOCUMENTS														
EXAMINER O-a DATE CONSIDERED 24 AvguSt 2006														
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.														

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	ECOND	et 1 of 1 IDS LIST OF		Atty. Docket No.: 4685	Serial No.: 10/829,306							
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U. S. PATENT DOCUMENTS												
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FOREIGN PATENT DOCUMENTS												
		DOCUMENT NO. DATE		COUNTRY	Cl.	Sub- Cl.	English					
A D. 4.	AC	07-321409	12/1995	Japan	-	_	Abstract					
A.O.A.	AD	09-293937	11/1997	Japan	-	Abstract						
	OTHER DOCUMENTS											
EXAMINER'S SIGNATURE				DATE CONSIDERED								
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*EXAMINER: line throug communicati	gh citai	tion if not in con	sidered, informance	whether or not citation is in confor and not considered. Include copy of	rmance this	with MI	PEP 609; th next	Draw				